Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/534,551	IGAWA ET AL.	
Examiner	Art Unit	
John S. Chu	1752	

SEARCHED				
Class	Subclass	Date	Examiner	
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430	326	6(2006	ge	
430	328		()	
430	330			
430	394			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH IN FILE	6/2006	Je.
INVENTOR SEARCH IN EAST		